Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | HIYAMA ET AL. | Examiner | Art Unit | Page 1 of 1 |

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0190215	12-2002	Tashiro et al.	250/370.11
*	В	US-6,975,356	12-2005	Miyamoto, Yoshihiro	348/308
*	С	US-6,498,332	12-2002	Funakoshi, Haruhiro	250/208.1
*	٥	US-6,734,908	05-2004	Watanabe et al.	348/308
*	ш	US-6,801,255	10-2004	Inui, Fumihiro	348/241
	F	US-			
	G	US-			
	Ξ	US-			
	_	US-			
	3	US-			
	К	US-			
Ü	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
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	×					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.